

Product Specification

XBLW NTTFS5826NL

N-Channel Enhancement Mode MOSFET











Description

The NTTFS5826NL uses advanced trench technology to provide excellent RDS(ON), low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application

General Features

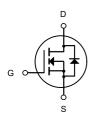
- ➤ VDS = 60V ID =30 A
- \triangleright RDS(ON) < 37m Ω @ VGS=10V

Application

- Battery protection
- Load switch
- Uninterruptible power supply



DFN3X3-8L



N-Channel MOSFET

Package Marking and Ordering Information

Product Model	Package Type	Marking	Packing	Packing Qty
XBLW NTTFS5826NL	DFN3X3-8L	5826	Tape	5000Pcs/Reel

Absolute Maximum Ratings (TC=25°Cunless otherwise noted)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	60	V
VGS	Gate-Source Voltage	±20	V
I _D @T _C =25°C	Continuous Drain Current, V _{GS} @ 10V ¹	30	А
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ 10V ¹	15	А
IDM	Pulsed Drain Current ²	46	А
EAS	Single Pulse Avalanche Energy ³	25.5	mJ
IAS	Avalanche Current	22.6	А
P _D @T _C =25°C	Total Power Dissipation ⁴	34.7	W
TSTG	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
R₀JA	Thermal Resistance Junction-ambient ¹	62	°C/W
R₀JC	Thermal Resistance Junction-Case ¹	3.6	°C/W



Electrical Characteristics (TJ=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} =0 V , I_D =250 u A	60		-	V
$\triangle BV_{DSS}/\triangle T_{J}$	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =1mA		0.063		V/°C
В	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =15A		31	37	0
R _{DS(ON)}	Static Drain-Source On-Resistance	V_{GS} =4.5V , I_D =10A		38	46	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	\/ -\/ -250\	1.2		2.5	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	$V_{GS}=V_{DS}$, $I_D=250uA$		-5.24		mV/°C
	Drain Source Lookage Current	V _{DS} =48V , V _{GS} =0V , T _J =25°C			1	uA
I _{DSS}	Drain-Source Leakage Current	V _{DS} =48V , V _{GS} =0V , T _J =55°C			5	
I _{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 20V$, $V_{DS}=0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =5V , I _D =15A		17		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		3.2		Ω
Q_g	Total Gate Charge (4.5V)			12.6		
Q _{gs}	Gate-Source Charge	V _{DS} =48V , V _{GS} =4.5V , I _D =12A		3.2		nC
Q _{gd}	Gate-Drain Charge	7		6.3		1
T _{d(on)}	Turn-On Delay Time			8		
Tr	Rise Time	V_{DD} =30V , V_{GS} =10V , R_{G} =3.3 Ω ,		14.2		
T _{d(off)}	Turn-Off Delay Time	I _D =10A		24.4		ns
T _f	Fall Time	1		4.6		
C _{iss}	Input Capacitance			1378		
C _{oss}	Output Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		86		pF
C _{rss}	Reverse Transfer Capacitance			64		

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,5}	V =V =0V Force Current			30	Α
I _{SM}	Pulsed Source Current ^{2,5}	V _G =V _D =0V , Force Current	1		46	Α
V_{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25°C			1.2	٧

Note:

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%
- 3.The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V,L=0.1mH,I_{AS}=22.6A
- 4.The power dissipation is limited by 150°C junction temperature
- 5. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.

XBLW Version1.0



Typical Characteristics

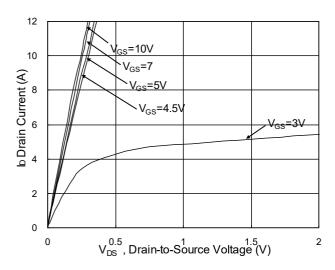


Fig.1 Typical Output Characteristics

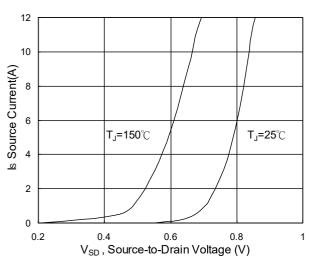


Fig.3 Forward Characteristics of Reverse

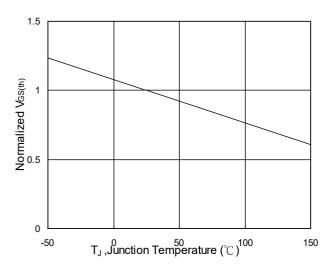


Fig.5 Normalized $V_{\text{GS(th)}}$ v.s T_{J}

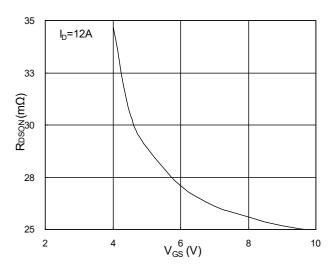


Fig.2 On-Resistance v.s Gate-Source

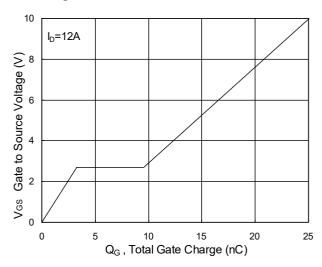


Fig.4 Gate-Charge Characteristics

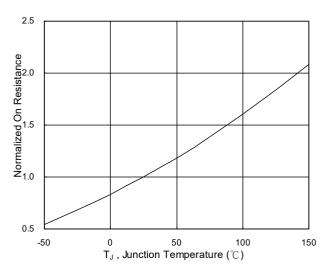
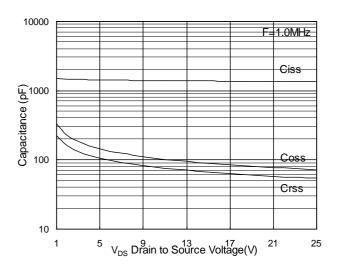


Fig.6 Normalized R_{DSON} v.s T_J



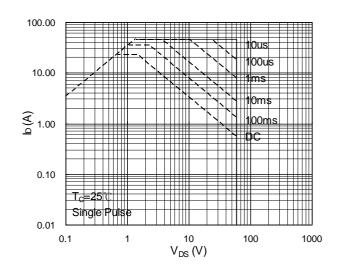


Fig.7 Capacitance

Fig.8 Safe Operating Area

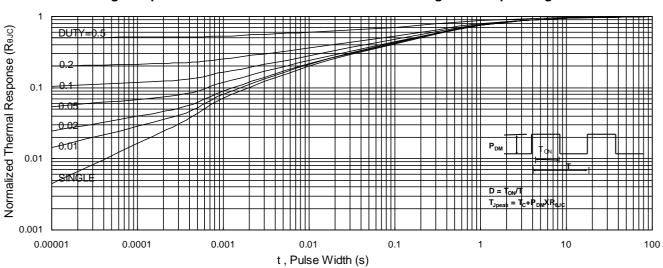


Fig.9 Normalized Maximum Transient Thermal Impedance

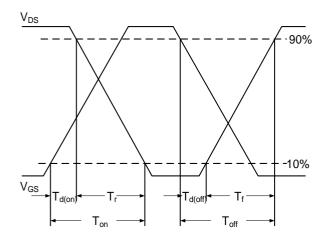


Fig.10 Switching Time Waveform

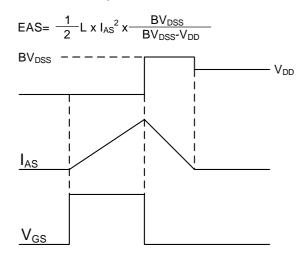
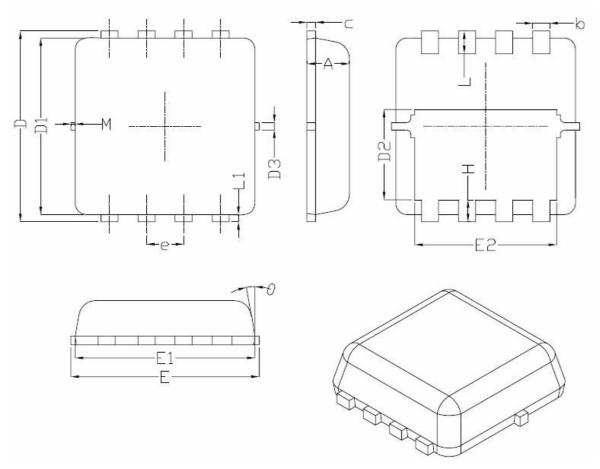


Fig.11 Unclamped Inductive Waveform



Package Information

DFN3X3-8L



Symbol	Dimensions In Millimeters			
Symbol	Min.	Nom.	Max.	
Α	0.70	0.75	0.80	
b	0.25	0.30	0.35	
С	0.10	0.15	0.25	
D	3.25	3.35	3.45	
D1	3.00	3.10	3.20	
D2	1.48	1.58	1.68	
D3	-	0.13	-	
Е	3.20	3.30	3.40	
E1	3.00	3.15	3.20	
E2	2.39	2.49	2.59	
е		0.65BSC		
Н	0.30	0.39	0.50	
L	0.30	0.40	0.50	
L1	-	0.13	-	
М	*	*	0.15	
θ		10°	12°	



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